



Antenna Data Sheet

Manufacturer	Shenzhen kenhaitong antenna technology co, ltd				
Address	3rd floor, west of No.1 Building, Hezhou Zhongnuo Industrial Park, Hangcheng Street, Bao'an District, Shenzhen				
Sample Name					
Part Number	2BNSM-S70				
Specification					
Inspection Item	Performance	Total Appearance	structure	Others	Inspection Result
Remark					
QA Audit		Engineer Audit		Sales Confirm	
The following are filled by Customer					
Customer Evaluation					
Signation/ Chapter by Customer	date:				

2.4GHz 3216 Chip Antenna: RAN3216F0P2G45

Application:

WLAN, 802.11b/g, Bluetooth, etc...

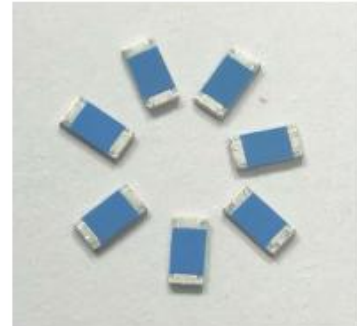
Features

SMD, high reliability, ultra Impact, Omni-directional...

Part number

RAN 3216 - F0 P 2G45
(1) (2) (3) (4) (5)

(1)Product Type	Chip Antenna
(2)Size Code	3.2x1.6mm
(3)Type Code	F0
(4)Packing	Paper Tape
(5)Frequency	2.45GHz

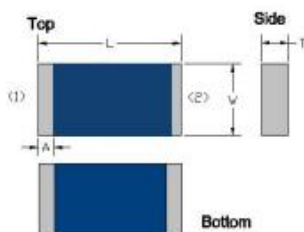


Electrical Specification

Working Frequency Range	2400 ~2484 MHz
Peak Gain	2.58 dBi (Typ.)
Impedance	50 Ohm
Return loss	10 dB (Min)
Polarization	Linear
Azimuth Beamwidth	Omni-directional
Operation Temperature(°C)	-40 ~85°C

The specification is defined on EVB.

Dimension and Terminal Configuration

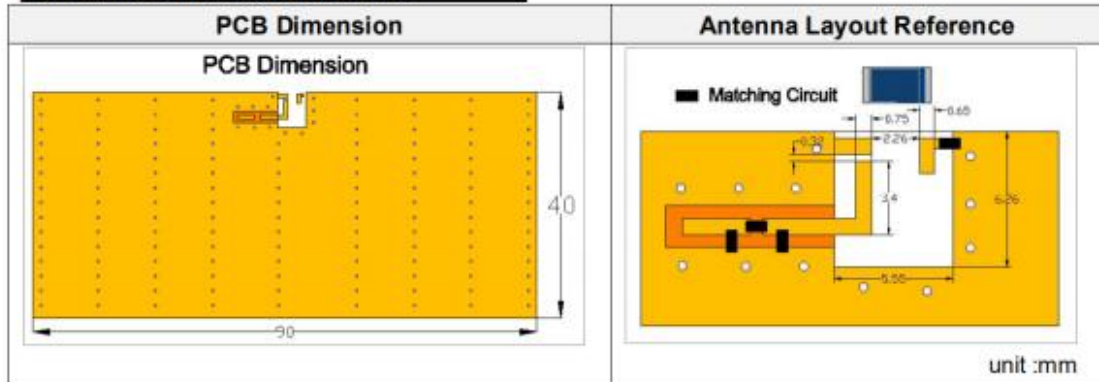


Dimension (mm)	
L	3.15±0.15
W	1.55±0.15
T	0.50±0.10
A	0.35±0.10

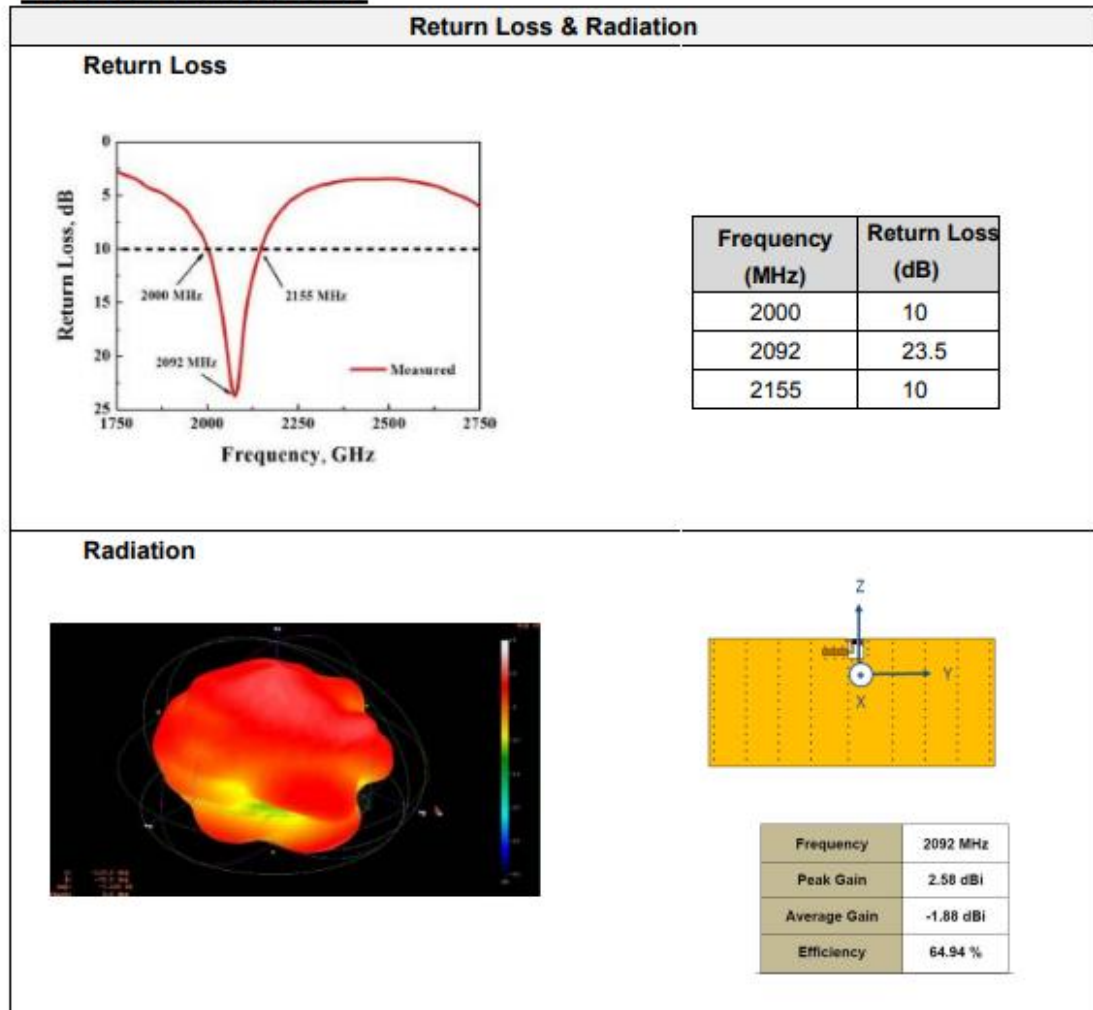
No.	Terminal Name
1	Feeding point
2	GND

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Evaluation Board Reference



Electrical Characteristics



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Taping Specifications

Reel and Taping Specification

Reel Specification

Diagram illustrating the Reel Specification. The left view is a top-down circular view of the reel with dimensions: ϕB (outer diameter), ϕC (inner diameter), and A (width of the central hub). The right view is a side view showing the reel's profile with dimensions: W (width), ϕD (inner diameter), and ϕM (outer diameter).

TYPE	SIZE		A	ϕB	ϕC	ϕD	W	ϕM
3216	7"	5K/Reel	2.0 \pm 0.5	13.5 \pm 1.0	21 \pm 1.0	60 \pm 1.0	11.5 \pm 2.0	178 \pm 2.0

Taping Specification

Diagram illustrating the Taping Specification. The left view is a top-down view of the tape with dimensions: A (width of the tape), B (width of the carrier), P (pitch), D (hole diameter), H (hole offset), G (hole offset), E (hole offset), F (hole offset), W (width of the tape), and I (width of the carrier). The right view is a side view showing the tape's profile with dimensions: W (width) and I (width of the carrier).

Packaging	Type	A	B	W	E	F	G	H	T	ϕD	P
Paper Type	3216	1.90 \pm 0.20	3.50 \pm 0.20	8.0 \pm 0.20	1.75 \pm 0.10	3.5 \pm 0.05	4.0 \pm 0.10	2.0 \pm 0.05	0.75 \pm 0.10	1.50 ^{+0.10} ₋₀	4.0 \pm 0.1

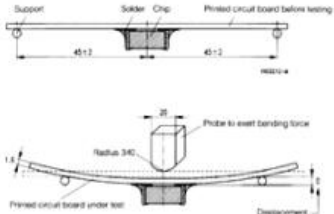
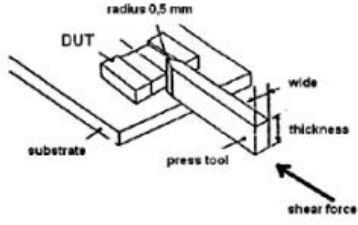


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Reliability Table

Test Item	Procedure	Requirements Ceramic Type	Remark (Reference)
Electrical Characterization		Fulfill the electrical specification	User Spec.
Thermal Shock	1. Preconditioning: 50 ± 10 °C / 1 hr , then keep for 24 ± 1 hrs at room temp. 2. Initial measure: Spec: refer Initial spec. 3. Rapid change of temperature test: -30 °C to +85 °C; 100 cycles; 15 minutes at Lower category temperature; 15 minutes at Upper category temperature.	No Visible Damage. Fulfill the electrical specification.	MIL-STD-202 107
Temperature Cycling	1. Initial measure: Spec: refer Initial spec. 2. 100 Cycles (-30 °C to +85 °C), Soak Mode=1 (2 Cycle/hours). 3. Measurement at 24 ± 2Hours after test condition.	No Visible Damage. Fulfill the electrical specification.	JESD22 JA104
High Temperature Exposure	1. Initial measure: Spec: refer Initial spec. 2. Unpowered; 500hours @ T=+85 °C. 3. Measurement at 24 ± 2 hours after test.	No Visible Damage. Fulfill the electrical specification.	MIL-STD-202 108
Low Temperature Storage	1. Initial measure: Spec: refer Initial spec. 2. Unpowered; 500hours @ T= -30 °C. 3. Measurement at 24 ± 2 hours after test.	No Visible Damage. Fulfill the electrical specification.	MIL-STD-202 108
Solderability (SMD Bottom Side)	Dipping method: a. Temperature: 235 ± 5 °C b. Dipping time: 3 ± 0.5s	The solder should cover over 95% of the critical area of bottom side.	IEC 60384-21/22 4.10
Soldering Heat Resistance (RSH)	Preheating temperature: 150 ± 10 °C. Preheating time: 1~2 min. Solder temperature: 260 ± 5 °C. Dipping time: 5 ± 0.5s	No Visible Damage.	IEC 60384-21/22 4.10
Vibration	5g's for 20 min., 12 cycles each of 3 orientations Note: Use 8"X5" PCB .031" thick 7 secure points on, one long side and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from 10-2000 Hz	No Visible Damage.	MIL-STD-202 Method 204
Mechanical Shock	Three shocks in each direction shall be applied along the three mutually perpendicular axes of the test specimen (18 shocks) Peak value: 1,500g's Duration: 0.5ms Velocity change: 15.4 ft/s Waveform: Half-sine	No Visible Damage.	MIL-STD-202 Method 213
Humidity Bias	1. Humidity: 85% R.H., Temperature: 85 ± 2 °C. 2. Time: 500 ± 24 hours. 3. Measurement at 24 ± 2hrs after test condition.	No Visible Damage. Fulfill the electrical specification.	MIL-STD-202 Method 106

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Board Flex (SMD)	<p>1. Mounting method: IR-Reflow. PCB Size (L:100 × W:40 × T:1.6mm)</p> <p>2. Apply the load in direction of the arrow until bending reaches 2 mm.</p> 	No Visible Damage.	AEC-Q200 005
Adhesion	<p>Force of 1.8Kg for 60 seconds.</p> 	No Visible Damage Magnification of 20X or greater may be employed for inspection of the mechanical integrity of the device body terminals and body/terminal junction.	AEC-Q200 006
Physical Dimension	<p>Any applicable method using x10 magnification, micrometers, calipers, gauges, contour projectors, or other measuring equipment, capable of determining the actual specimen dimensions.</p>	In accordance with specification.	JESD22 JB100